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# P-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$ Max.	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)		
	$0.195 \text{ at V}_{GS} = -10 \text{ V}$	- 5.8			
- 100	0.200 at V <sub>GS</sub> = - 7.5 V	- 5.7	12		
	0.207 at V <sub>GS</sub> = - 6 V	- 5.6			

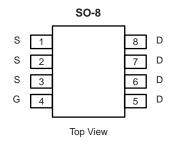
#### **FEATURES**

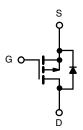
- DT-Trench Power MOSFET
- 100 %  $R_g$  and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



#### **APPLICATIONS**

- DC/DC Converters
- Motor Control





P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	- 100	V		
Gate-Source Voltage	V <sub>GS</sub>	± 20	V		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 25 °C	1_	- 5.8	A	
Continuous Diain Current (1) = 150°C)	T <sub>C</sub> = 70 °C		- 5.1		
Pulsed Drain Current	I <sub>DM</sub>	- 17.4	А		
Avalanche Current	I <sub>AS</sub>	- 12			
Single Avalanche Energy <sup>a</sup>	L = 0.1 mH	E <sub>AS</sub>	12.2	mJ	
	T <sub>C</sub> = 25 °C	D	32.1 <sup>b</sup>	W	
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 25 °C <sup>c</sup>	$ P_{D}$	2.5		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS					
Parameter	Symbol	Limit	Unit		
Junction-to-Ambient (PCB Mount) <sup>c</sup>	R <sub>thJA</sub>	50	°C/W		
Junction-to-Case (Drain)	R <sub>thJC</sub>	3.9			

#### Notes:

- a. Duty cycle  $\leq$  1 %.
- b. See SOA curve for voltage derating.c. When mounted on 1" square PCB (FR-4 material).

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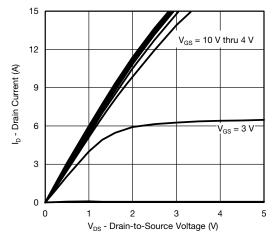
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{DS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 100			V	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.5		- 3.5	V	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 250	nA	
		V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V			- 1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C			- 50		
		V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C			- 250		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -10 \text{ V}, V_{GS} = -10 \text{ V}$	- 10			Α	
		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 3.6 A		0.162	0.195	Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 7.5 V, I <sub>D</sub> = - 3.5 A		0.166	0.200		
		V <sub>GS</sub> = - 6 V, I <sub>D</sub> = - 3.5 A		0.172	0.207		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 20 V, I <sub>D</sub> = - 3.6 A		12		S	
Dynamic <sup>b</sup>		,					
Input Capacitance	C <sub>iss</sub>			1110		pF	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = -50 \text{ V}, f = 1 \text{ MHz}$		64			
Reverse Transfer Capacitance	C <sub>rss</sub>	]		40			
Total Gate Charge <sup>c</sup>	$Q_g$	V <sub>DS</sub> = - 50 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 3.6 A	23.5		35.3		
Total Gate Charge	<b>G</b> g			12	18	nC	
Gate-Source Charge <sup>c</sup>	$Q_{gs}$	$V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3.6 \text{ A}$		4			
Gate-Drain Charge <sup>c</sup>	$Q_{gd}$			5.3			
Gate Resistance	Rg	f = 1 MHz	1.3	6.5	13	Ω	
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			6	12		
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = -50 \text{ V}, R_L = 17.2 \Omega$		9	18	no	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong$ - 2.9 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		35	53	ns	
Fall Time <sup>c</sup>	t <sub>f</sub>			10	20		
Drain-Source Body Diode Ratings at	nd Characteri	stics T <sub>C</sub> = 25 °C <sup>b</sup>					
Continuous Current	I <sub>S</sub>				- 5.8	Α	
Pulsed Current	I <sub>SM</sub>	SM			- 17.4	^	
Forward Voltage <sup>a</sup>	$V_{SD}$	I <sub>F</sub> = - 2.9 A, V <sub>GS</sub> = 0 V		- 0.83	- 1.5	V	
Reverse Recovery Time	t <sub>rr</sub>			46	69	ns	
Peak Reverse Recovery Current	I <sub>RM(REC)</sub>	I <sub>F</sub> = - 2.9 A, dl/dt = 100 A/μs		- 4.5	- 5.8	Α	
Reverse Recovery Charge	Q <sub>rr</sub>	1		98	147	nC	

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing. c. Independent of operating temperature.

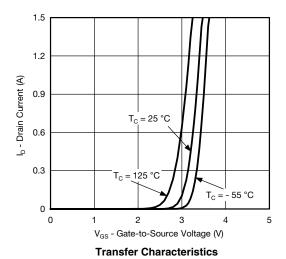
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

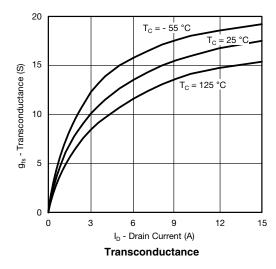


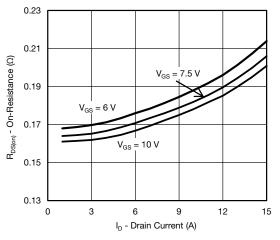
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



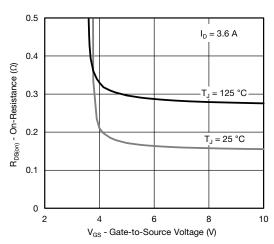
#### **Output Characteristics**



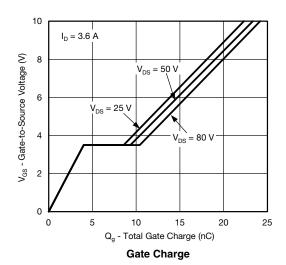




**On-Resistance vs. Drain Current** 

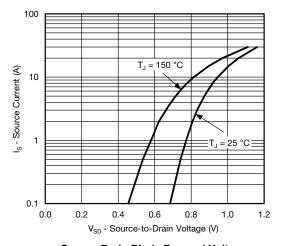


On-Resistance vs. Gate-to-Source Voltage

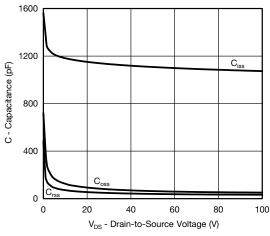




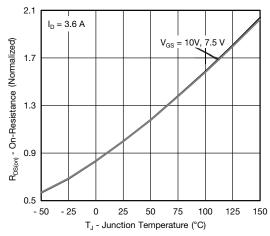
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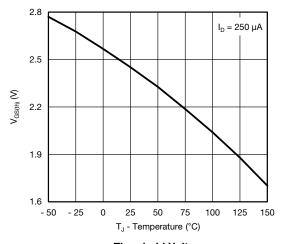
### Source-Drain Diode Forward Voltage



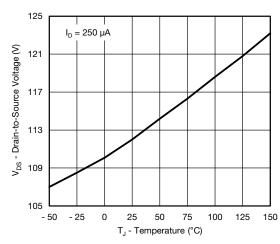
Capacitance



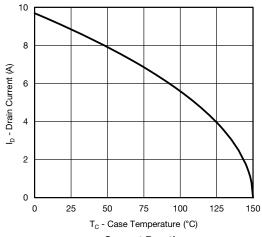
On-Resistance vs. Junction Temperature



**Threshold Voltage** 



Drain Source Breakdown vs. Junction Temperature

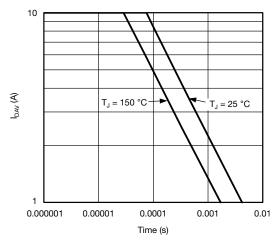


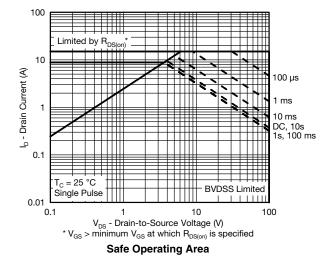
**Current Derating** 



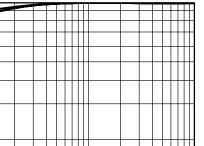


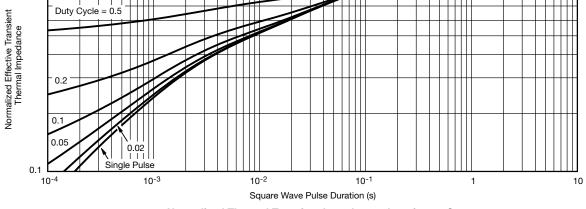
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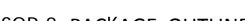


Single Pulse Avalanche Current Capability vs. Time





Normalized Thermal Transient Impedance, Junction-to-Case

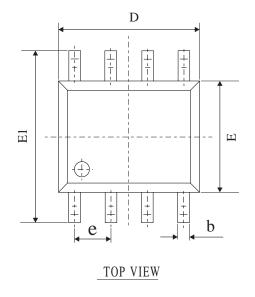


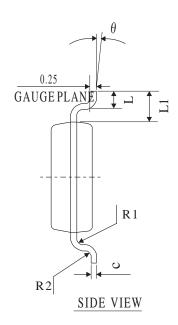
**Din-Tek** 

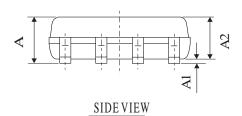
SEMICONDUCTOR

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# **SOP-8 PACKAGE OUTLINE**







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX
A	1.30	1.60	1.85
A1	0.03	0.15	0.28
A2	1.20	1.45	1.70
b	0.26	0.40	0.54
С	0.132	0.203	0.273
D	4.50	4.90	5.30
Е	3.50	3.00	4.30
E1	5.50	6.00	6.50
L	0.30	0.70	1.10
θ	2°	4°	6°
L1	1.04REF		
e	1.27BSC		
R1	0.07TYP		
R2	0.07TYP		





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